

Position-sensitive device

Bodo Kaiser

Ludwig-Maximilians-Universität München

bodo.kaiser@physik.uni-muenchen.de

April 6, 2019

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1 Introduction

2 Position-sensitive detector

[1]

Parameter	Symbol	Values		Unit
		Typical	Maximum	
Dark current	I_d	0.5	10	nA
Interelectrode resistance	R_e	7	15	k Ω
Terminal capacitance	C_t	150	300	pF

Table 1: Important parameters of the S5990 extracted from the datasheet [2].

3 Preamplifier

The photocurrents created by our detector are in the range of microampere where they are vulnerable to noise. Using a preamplifier, we can increase the amplitude of the signal for an improved signal-to-noise ratio. The typical photocurrent preamplifier is based on the transimpedance (current-to-voltage) amplifier design using a voltage-feedback operational amplifier. Converting the current to a voltage signal has the benefit that the voltage signal can be easily visualized with an oscilloscope. Furthermore, the voltage-feedback operational amplifier design appears to be more common than the current-feedback operational amplifier, as manufacturers offer much more choice and they are more prominent in the literature. That said, current feedback operational amplifiers are reported to be a viable solution for high-speed and high-bandwidth applications, see Ref. [3, p. 110] for an overview of the benefits of current feedback amplifiers and Ref. [4, Ch. 9] for a comparison.

3.1 Gain

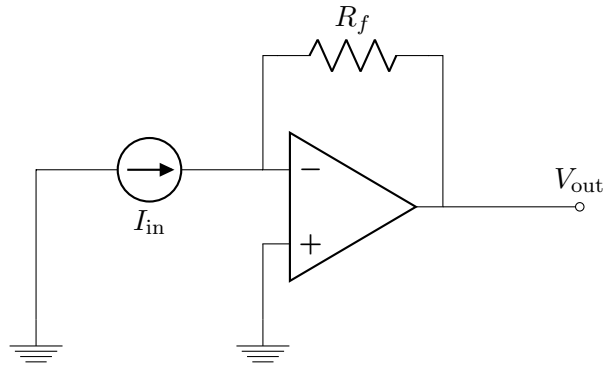


Figure 1: Simple transimpedance amplifier circuit.

$$V_{out} = R_f I_{in} \quad (1)$$

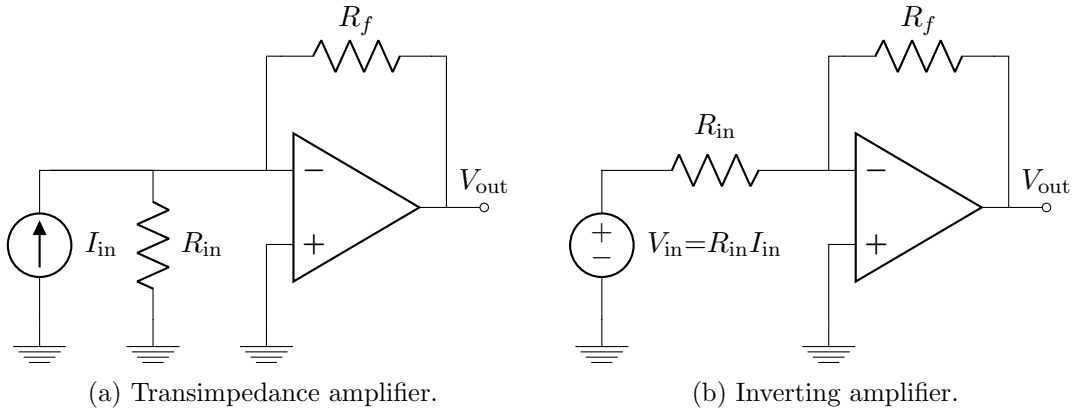


Figure 2: Equivalence between transimpedance and inverting amplifier using source transformation.

3.2 Offset

3.2.1 Input offset voltage

[3, p. 54]

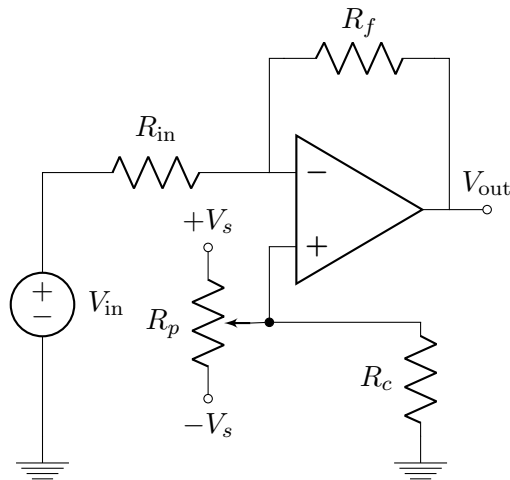


Figure 3: Input current offset compensation.

3.2.2 Input bias current

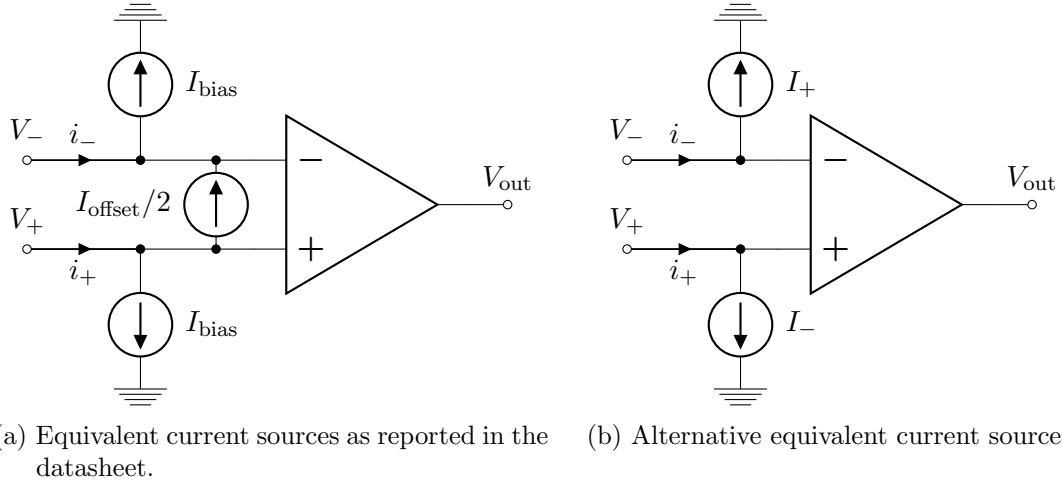


Figure 4: Non-zero input current from the operational amplifier.

$$I_+ = I_{bias} + \frac{1}{2}I_{offset} \quad I_{offset} = I_+ - I_- \quad (2)$$

$$I_- = I_{bias} - \frac{1}{2}I_{offset} \quad I_{bias} = \frac{I_+ + I_-}{2} \quad (3)$$

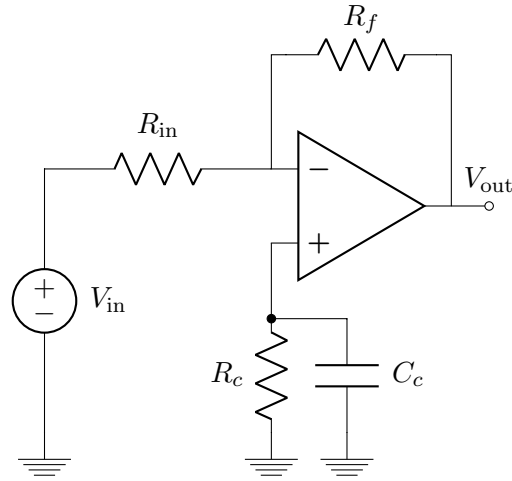


Figure 5: Input current offset compensation.

[3, p. 57] [5, p. 25]

$$R_c = \frac{R_{\text{in}} R_f}{R_{\text{in}} + R_f} \quad (4)$$

3.3 Noise

3.4 Stability

[6, p. 693] [7, p. 183] [4, Ch. 5] [5, Ch. 3]

Glossary

S5990 Hamamatsu two-dimensional PSD. 3

References

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